

## OPTIMIZATION OF ZINC SULFIDE (ZnS) ELECTRON AFFINITY IN COPPER INDIUM SULFIDE (CIS) BASED PHOTOVOLTAIC CELL

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In this paper, the CuInS<sub>2</sub> thin film photovoltaic cell is presented by optimizing zinc sulfide (ZnS) electron affinity with different CuInS<sub>2</sub> carrier concentration using Silvaco TCAD. The ZnS material is suitable candidates to replace the CdS material as a buffer layer in CIS photovoltaic cell. Moreover, it is found that the performance of CuInS<sub>2</sub> thin film solar cell is relatively dependent on value ZnS electron affinity and carrier concentration of CuInS<sub>2</sub>. The structure, electrical properties and optical properties is simulated in order to find the optimum ZnS electron affinity, and leading to the optimum value is obtained at  $\chi=4.5$  eV. The structure of CuInS<sub>2</sub> thin film photovoltaic cell is controlled by the  $\chi=4.5$  eV with  $1 \times 10^{16} \text{cm}^{-3}$  and  $6.8 \times 10^{17} \text{cm}^{-3}$  of CuInS<sub>2</sub> carrier concentration. The simulation shows the  $J_{sc}=25.76 \text{ mA/cm}^2$ ,  $V_{oc}=1.04 \text{ V}$ , fill factor=82.94 % and efficiency=33.59% by using  $1 \times 10^{16} \text{cm}^{-3}$  of CuInS<sub>2</sub> carrier concentration has better performance compared to the  $6.8 \times 10^{17} \text{cm}^{-3}$  of CuInS<sub>2</sub> carrier concentration.

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### 1. Introduction

The Cu-chalcophyrite thin film has played the role in photovoltaic technology. The typical Cu-chalcophyrite based absorber materials are CuInS<sub>2</sub>, Cu(In,Ga)Se and CuIn(S,Se)<sub>2</sub>. Recently, CuInS<sub>2</sub> thin film has attracted the attention due to its low cost and suitable for substituting the selenium issue to non-toxic sulfur. However, the drawback for this low cost and environment friendly CuInS<sub>2</sub> based solar cell, it gives the lowest efficiency. The highest conversion efficiency for CuInS<sub>2</sub> has reached 10.4% [1] and considerably lower than cell based on Cu(In,Ga)Se of 20.3% [2] and CuIn(S,Se)<sub>2</sub> of 12% [3]. As the potential of CuInS<sub>2</sub> based photovoltaic technology expand, a better understanding for different buffer and absorber materials is required. Extensive research has been done on zinc sulfide (ZnS) as an alternative buffer material to cadmium sulfide (CdS) in polycrystalline photovoltaic device. The ZnS is most promising material where it has a wide band gap of 3.7 eV, high index of refraction and high transmittance in visible range of solar spectrum [4-7].

In this present work, the effect of ZnS bandgap with different CuInS<sub>2</sub> absorber carrier concentrations is investigated. Section II describes the simulation details of the CuInS<sub>2</sub> photovoltaic cell. In Section III, the results from optimization of ZnS electron affinity with different CuInS<sub>2</sub> absorber carrier concentration, current density-voltage (*J-V*) characteristics and external quantum efficiency (EQE) are presented.

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## 2. Methodology

The CuInS<sub>2</sub> solar cell consists of 0.3μm of Molybdenum layer deposited on soda lime glass (SLG) substrate and serving as a back contact for the photovoltaic cell. As the absorber photovoltaic material, CuInS<sub>2</sub> layer is deposited on top of Molybdenum with carrier concentration  $1 \times 10^{16} \text{ cm}^{-3}$  with 2 μm thick. The heterojunction is then completed by deposition of 0.05 μm,  $1 \times 10^{16} \text{ cm}^{-3}$  ZnS buffer layer and followed by undoped ZnO layer with thickness of 0.05 μm and  $1 \times 10^{18} \text{ cm}^{-3}$  carrier concentration. The top layer or known as window layer is heavily doped by  $1 \times 10^{20} \text{ cm}^{-3}$  of Al:ZnO (AZO) deposition with 0.3 μm thick as shown in Figure 1. The MgF<sub>2</sub> of ARC layer is deposited on top of the AZO surface to reduce the reflection of CuInS<sub>2</sub> photovoltaic cell [7].



Fig. 1. Schematic diagram of CuInS<sub>2</sub> photovoltaic layer structure

The Silvaco ATLAS is used to model the CuInS<sub>2</sub> based photovoltaic device with physical parameters such as kind of materials, composition, thickness and doping concentration as shown in Figure 1 and Table 1. For the optimizing the CuInS<sub>2</sub> absorber carrier concentration and the ZnS electron affinity, the short circuit current density-voltage (*J-V*) characteristics, fill factor (*FF*), conversion efficiency and EQE are calculated using by default equation in Silvaco [8]. The optical properties such as the Zn (S,O) refractive index, extinction coefficient and CuInS<sub>2</sub> absorber carrier concentration are obtained from experimental value from [9-11]. The CuInS<sub>2</sub> is simulated under AM 1.5 with 1sun (100mW/cm<sup>2</sup>) illumination.

Table 1. Physical parameters properties used in Silvaco TCAD for CIS photovoltaic cell

	AZO	ZnO	ZnS	CIS
Dielectric permittivity, $\epsilon$	8.49	8.49	8.3	13.6
Energy bandgap, $E_g$ (eV)	3.37	3.37	3.68	1.55
Electron affinity, $\chi$ (eV)	4.5	4.5	3.9	4.58
$N_c$ (per cc)	2.2E+18	2.2E+18	6.35E+18	2.2E+18
$N_v$ (per cc)	1.8E+19	1.8E+19	6.03E+19	1.8E+19

## 3. Result and discussion

### 3.1 Effects of various ZnS bandgap with different carrier concentrations of CIS absorber layer

The optimization of ZnS electron affinity is investigated in this numerical simulation. The values of electron affinity of ZnS are varied from 3.9 eV to 5.2 eV with CIS electron affinity is

remaining constant at 4.7 eV. Figure 2 shows the short current density, open circuit voltage, fill factor and efficiency as the function of the electron affinity in CuInS<sub>2</sub> photovoltaic cell. The performance of CuInS<sub>2</sub> photovoltaic cell is strongly dependent on ZnS electron affinity and different carrier concentration in the CuInS<sub>2</sub> absorber layer. Hence, the current density for CuInS<sub>2</sub> can be maximized by varying the value of electron affinity in ZnS buffer layer.

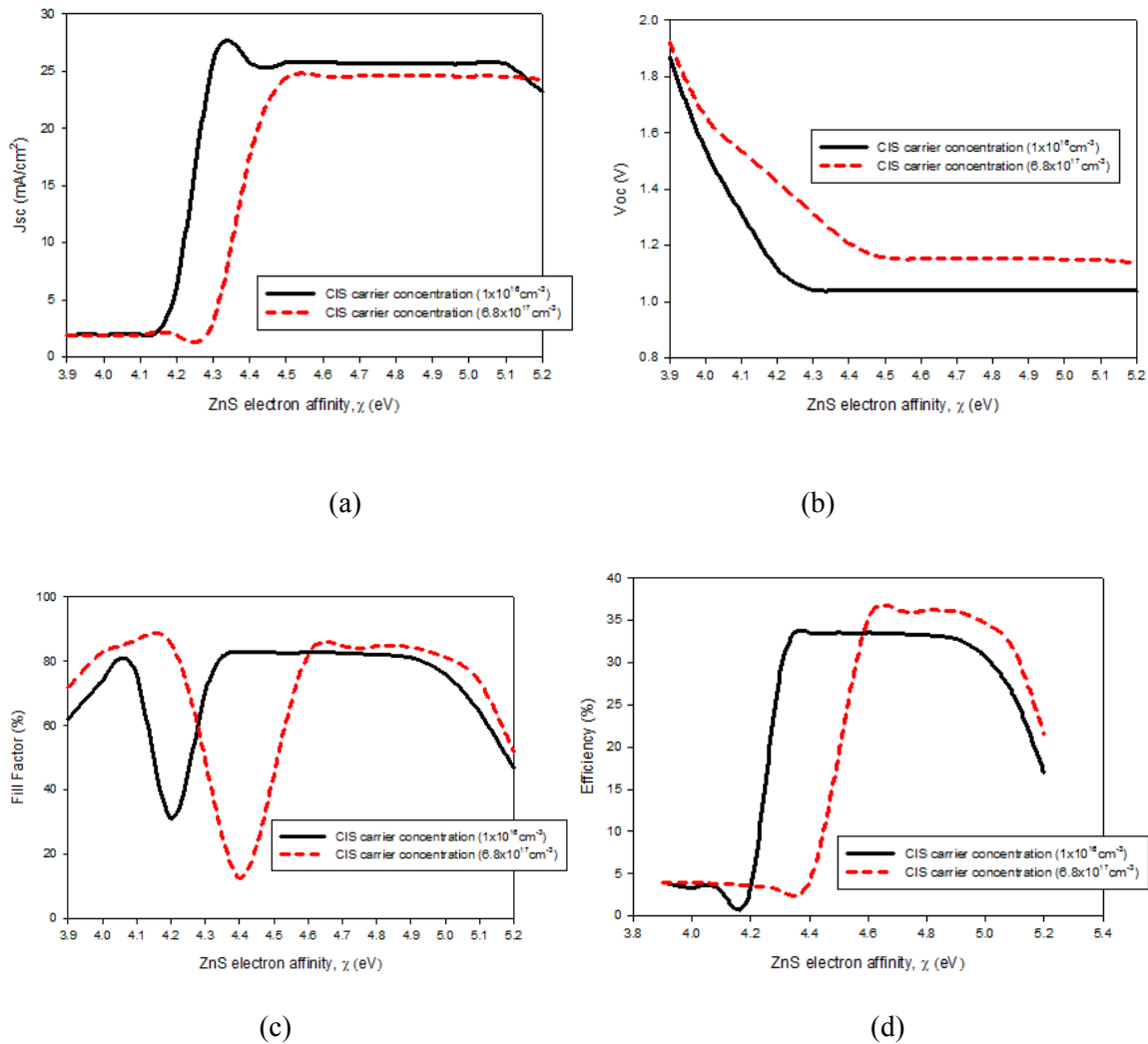


Fig. 2. Performance comparison of CuInS<sub>2</sub> photovoltaic cell with different absorber layer concentration.

The changes of performance of CuInS<sub>2</sub> can be seen in Figure 2 (a) as the electron affinity is increase. At  $\chi = 3.9$  eV, the  $J_{sc} = 1.88 \text{ mA/cm}^2$  is obtained for both different CIS absorber carrier concentration. As the electron affinity is increase to 4.4 eV, the  $J_{sc} = 25.77 \text{ mA/cm}^2$ . It is noted that  $J_{sc}$  is gradually decreased from  $J_{sc} = 25.76 \text{ mA/cm}^2$  to  $J_{sc} = 23.18 \text{ mA/cm}^2$ , as the electron affinity is increase from  $\chi = 4.5$  eV to  $\chi = 5.2$  eV as shown in  $J_{sc}$  graph in Figure 2 (a). For the concentration  $6.8 \times 10^{17} \text{ cm}^{-3}$  (red line), the  $J_{sc}$  value increase as the electron affinity increase from  $\chi = 3.9$  eV to  $\chi = 4.6$  eV. At the point  $\chi = 4.6$  eV, the  $J_{sc} = 24.60 \text{ mA/cm}^2$  and it is continuously decreased up to  $\chi = 5.2$  eV. The value for  $V_{oc}$  of the CuInS<sub>2</sub> photovoltaic cell from Figure 2 (b) is exponentially decreased from  $V_{oc} = 1.88$  V at the  $\chi = 3.9$  eV to  $\chi = 5.2$  eV where the  $V_{oc}$  is 1.04 V for lower concentration. As the CIS carrier concentration is  $6.8 \times 10^{17} \text{ cm}^{-3}$ , it is noted the value of  $V_{oc}$

is increase by 0.05 V. The Voc graph is exponentially decrease, same with the Voc graph at  $1 \times 10^{16} \text{cm}^{-3}$  carrier concentration.

By optimizing the electron affinity of ZnS at CIS carrier concentration  $1 \times 10^{16} \text{cm}^{-3}$ , the fill factor, FF can be obtained from Figure 2 (c). At  $\chi=3.9$  the FF is 62.14% and increase by 11.86 % with  $\chi=4.0$  eV. As the electron affinity is increase up  $\chi=4.2$ , the FF is drastically dropped to 30.91 %. In the case  $\chi=4.3$  eV to  $\chi=4.8$  eV, the FF rapidly increase from 70.39 % to 82.16 %. The decrement value of FF is 34.42%, as the electron affinity goes up from  $\chi=4.9$  eV to  $\chi=5.2$  eV. For CIS carrier concentration  $6.8 \times 10^{17} \text{cm}^{-3}$ , it can be seen the graph is shifted to the right from  $\chi=4.2$  eV to  $\chi=4.4$  eV. At the point  $\chi=4.4$  eV, the FF value is 12.55 % which smaller than 30.91 % at  $\chi=4.4$  eV for CIS carrier concentration at  $1 \times 10^{16} \text{cm}^{-3}$ .

The efficiency for CIS concentration for  $1 \times 10^{16} \text{cm}^{-3}$  and  $6.8 \times 10^{17} \text{cm}^{-3}$  can be identified as the ZnS electron affinity is varied. As the electron affinity is increase from  $\chi=3.9$  eV to  $\chi=4.1$  eV, the efficiency is decreased by 0.99% and dropped to 3.23% at  $\chi=4.2$ eV. The efficiency is drastically increase up from 28.72% at  $\chi=4.3$ eV to 33.59% at  $\chi=4.5$ eV. It can seen that at  $\chi=4.5$ eV, the smaller conduction band offset ZnS/CIS heterojunction the better its power conversion efficiency. By increasing the electron  $\chi=4.6$  to  $\chi=5.2$  eV, the percentage of efficiency shows the dropping behavior from 33.95% to 16.99% as shown in Fig.2. For CIS carrier concentration  $6.8 \times 10^{17} \text{cm}^{-3}$ , the shows the increment of efficiency behavior from  $\chi=3.9$  eV to  $\chi=4.2$  eV. The percentage efficiency at  $\chi=4.3$  eV is 4.01%, and continuously increase its efficiency 36.29% at  $\chi=4.7$  eV. From Fig.2, the dropping behavior of percentage efficiency from 36.13% to 21.58% are related to the increasing of electron affinity at  $\chi=4.8$  eV up to  $\chi=5.2$  eV. In Table 3, it is summarized the performance of  $\text{CuInS}_2$  as a function of ZnS electron affinity (attached in last page).

### 3.2 Comparison on two CIS carrier concentration with optimum ZnS electron affinity, $\chi=4.5$ eV

Fig. 3 shows the fourth quadrant current density versus voltage ( $J$ - $V$ ) curve of the  $\text{CuInS}_2$  photovoltaic cell under Air Mass 1.5 (AM 1.5) at 1 sun ( $100 \text{mW}/\text{cm}^2$ ) intensity. The  $\chi=4.5$ eV is chosen as the optimum value due to  $\Delta E=0.2$  eV conduction band offset and have good percentage of efficiency. From Fig.3, the  $J$ - $V$  curve gives the  $J_{sc}$  value at  $25.76 \text{mA}/\text{cm}^2$  and  $24.39 \text{mA}/\text{cm}^2$  for CIS carrier concentration at  $1 \times 10^{16} \text{cm}^{-3}$ . It is noted that the changes of the  $J$ - $V$  curves are strongly related to the CIS carrier concentration. By using the two different carrier concentration, the percentage of efficiency is dropping from 19.07% to 33.59%. These performance parameters of  $\text{CuInS}_2$  is comparable with the reported in [1] as shown in Table 2.

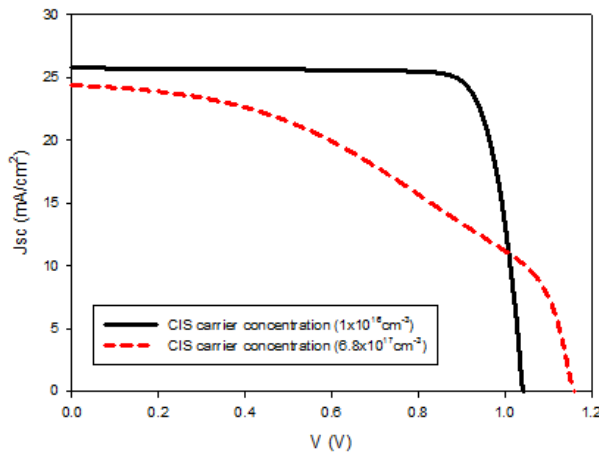


Fig. 3.  $I$ - $V$  curve at different CIS carrier concentration with  $\chi=4.5$  eV

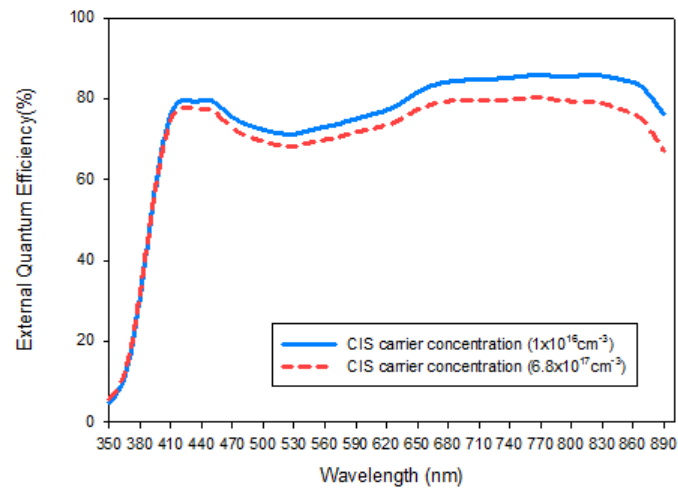


Fig. 4: EQE for CuInS<sub>2</sub> solar cell as a function of wavelength under  $\chi=4.5$  eV in ZnS layer at different carrier concentration of CuInS<sub>2</sub>.

The result of external quantum efficiency (EQE) of CuInS<sub>2</sub> photovoltaic solar cell is plotted in Fig.4. In the wavelength range of 440nm-890nm, the CIS carrier concentration  $1 \times 10^{16} \text{cm}^{-3}$  exhibit a higher EQE compared than CIS carrier concentration  $6.8 \times 10^{17} \text{cm}^{-3}$ . The highly transparency of ZnS buffer layer has leads the absorption at shorter wavelength range from 350nm to 440nm and decrease the short circuit current density  $1 \text{ mA/cm}^2$  corresponding to higher CuInS<sub>2</sub> carrier concentration.

Table 2 Parameters of the optimized carrier concentration in absorber layer with electron affinity,  $\chi=4.5$  eV

Solar cells	Jsc (mA/cm <sup>2</sup> )	Voc (V)	FF (%)	Efficiency (%)
Reference model [1]	24.50	0.70	65.80	10.4
CIS optimized at absorber layer ( $1 \times 10^{16} \text{cm}^{-3}$ )	25.76	1.04	82.94	33.59
CIS optimized at absorber layer ( $6.8 \times 10^{17} \text{cm}^{-3}$ )	24.39	1.15	44.82	19.07

The comparisons are given in Table 2 and Fig.4. It is clearly seen that to improvised the performance of CuInS<sub>2</sub> thin film photovoltaic cell with different CuInS<sub>2</sub> carrier concentration, EQE, Jsc, Voc, FF and efficiency has been achieved. Since the operation of photovoltaic cell includes the process of recombination, conduction band offset, and photon absorption, thus many parameters needs to take into account in order to improve the performance of solar cell especially in term of simulation. Further investigation is required in the next simulation especially in material defects, surface recombination and valence band offset.

Table 3: Parameters of the CuInS<sub>2</sub> photovoltaic cell with different CuInS<sub>2</sub> carrier concentration. Here Jsc is short current density, Voc is open circuit voltage, FF is fill factor

CIS concentration (cm <sup>-3</sup> )	ZnS Electron Affinity, $\chi$ (eV)	Jsc (mA/cm <sup>2</sup> )	Voc (V)	FF (%)	Efficiency (%)
1x10 <sup>16</sup>	3.9	1.88	1.87	62.14	3.95
	4.0	1.88	1.54	74.00	3.24
	4.1	1.97	1.31	75.67	2.96
	4.2	6.18	1.12	30.91	3.23
	4.3	25.85	1.04	70.39	28.72
	4.4	25.77	1.04	82.79	33.54
	4.5	25.76	1.04	82.74	33.59
	4.6	25.75	1.04	82.84	33.55
	4.7	25.74	1.04	82.60	33.45
	4.8	25.72	1.04	82.16	33.25
	4.9	25.70	1.04	81.17	32.84
	5.0	25.68	1.04	76.06	30.75
5.1	25.64	1.04	64.28	25.92	
5.2	23.18	1.04	46.75	16.99	
6.8x10 <sup>17</sup>	3.9	1.88	1.92	71.76	3.92
	4.0	1.88	1.66	82.81	3.91
	4.1	1.88	1.54	86.68	3.79
	4.2	1.91	1.42	85.52	3.51
	4.3	2.99	1.31	49.35	2.93
	4.4	17.54	1.21	12.55	4.01
	4.5	24.39	1.16	44.82	19.07
	4.6	24.60	1.15	81.93	35.07
	4.7	24.60	1.15	84.80	36.29
	4.8	24.57	1.15	84.75	36.25
	4.9	24.58	1.15	84.52	36.13
	5.0	24.56	1.15	81.28	34.70
5.1	24.54	1.15	73.70	31.37	
5.2	24.27	1.14	51.73	21.58	

#### 4. Conclusion

The CuInS<sub>2</sub> thin film photovoltaic cell is designed by optimizing the conduction band offset of ZnS /CIS heterojunction with two difference carrier concentration. It is found that electron affinity,  $\chi=4.5$  eV is optimum value with  $\Delta E=0.2$  eV of conduction band offset. Our results demonstrate the performance of the CuInS<sub>2</sub> is improved from 19.07% to 33.59% under AM 1.5 for the CIS carrier concentration 1x10<sup>16</sup>cm<sup>-3</sup> under 100mW/cm<sup>2</sup> illumination. Based on by the previous experimental value which added in new design, we observed that the performance results of CuInS<sub>2</sub> baseline model can be comparable with our CuInS<sub>2</sub> design and hence may gives a better understanding behind the physics behavior especially in CuInS<sub>2</sub> thin film photovoltaic cell.

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